

Notice of References Cited	Application/Control No. 10/501,349		Applicant(s)/Patent Under Reexamination WATANABE ET AL.	
	Examiner David Goodwin		Art Unit 2818	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-5,184,106	02-1993	Partin et al.	338/32R
*	C	US-6,861,679	03-2005	Otsuka et al.	257/194
*	D	US-6,809,514	10-2004	Ashley et al.	324/251
*	E	US-6,630,882	10-2003	Heremans et al.	338/32H
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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